ON Semiconductor



Title of Change:	NCV7321 Datasheet update – Revision 12
Effective date:	21 July 2015
Contact information:	Contact your local ON Semiconductor Sales Office or <roman.buzas@onsemi.com></roman.buzas@onsemi.com>
Type of notification:	ON Semiconductor will consider this change accepted.
Change category:	🗌 Wafer Fab Change 🔄 Assembly Change 🗌 Test Change 🛛 Other
Change Sub-Category(s):	
Sites Affected:	pplicable ON Semiconductor site(s) : External Foundry/Subcon site(s)
Description and Purpose: detailed description of the change and reason for the change.	
 Page 1: Quality statement updated NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable. These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant Page 1: Features list updated LIN Transceiver Supports K-Line Bus Architecture LIN Compliant to latest LIN Physical Layer Specification Revision 2.x New device derivative introduction NCV7321-2 ESD Improved Stand-alone LIN Transceiver NCV7321D12R2G - SOIC-8 package NCV7321MW2R2G - DFN8 package DFN8 package info added (CASE 506BW, package drawing, marking, pinout, pin description, package dimensions, thermal characteristics) Table 4: Absolute Maximum Ratings update (Improved ESD ratings for new device derivative) 	
List of affected Standard Parts: NCV7321D10G NCV7321D10R2G NCV7321D11G NCV7321D11R2G NCV7321D12R2G NCV7321MW2R2G	